

LIFT@Keck: Analysis of performance and first experimental results

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[D. Mawet's talk monday]

- Upgrade of Keck II AO system (KPIC) → need for a low-order (NGS) sensor in LGS mode
- Near-infrared tip/tilt sensor on Keck I (TRICK) proven efficient → interest for a NIR focal plane sensor
- LIFT: low-order focal-plane sensor developed at Onera

 \rightarrow Occasion for a fully operational demonstration for LIFT

 \rightarrow Optimized low-order sensing for Keck

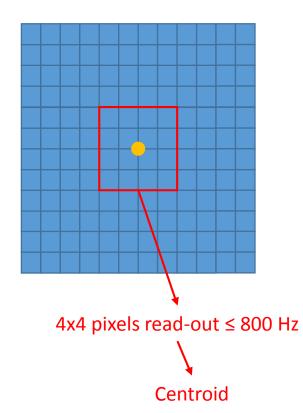
- 2 tracks:
 - LIFT as new sensor for Keck II (new design)
 - LIFT as an upgrade of TRICK for Keck I (same design)





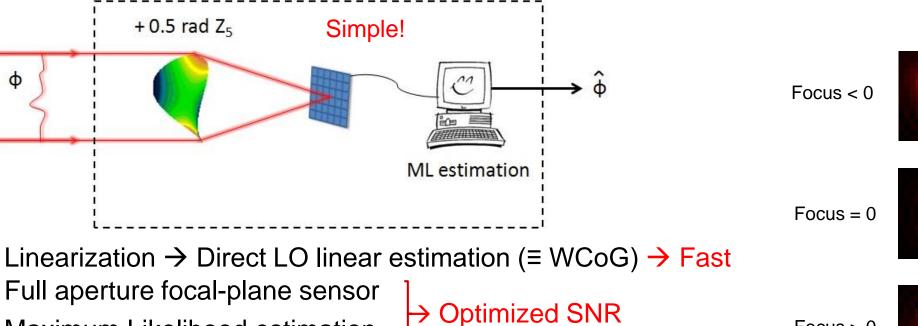


- H2RG camera
- 50 mas pixel
- Sensing band: H (λ/D = 34 mas) or Ks (λ/D = 44 mas)
- RON: 5 e- at 800 Hz, 2.8 e- at 100 Hz
- Negligible dark current





LIFT: LInearized Focal-plane Technique



Maximum Likelihood estimation

+ 0.5 rad Z₅

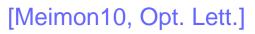
Astigmatism offset: removes the focus sign ambiguity

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\rightarrow Simple, fast, high SNR

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Focus > 0

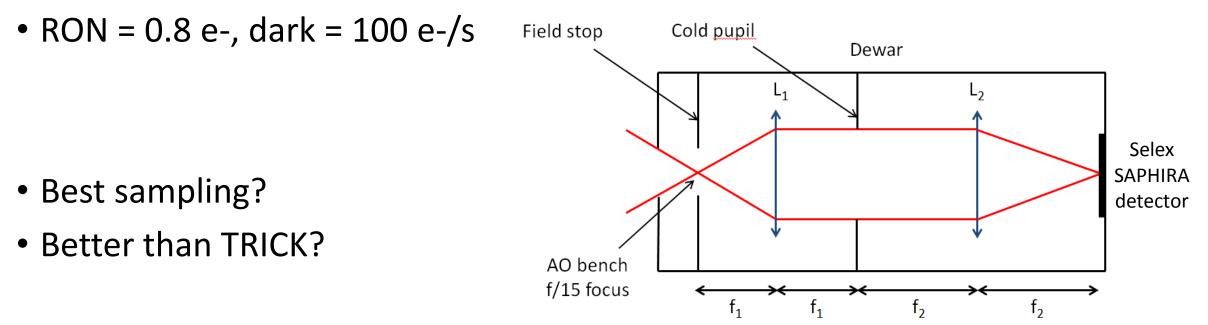
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LIFT on Keck II: conceptual design



- Only requirement: change f/# to get the desired sampling \rightarrow simple design
- Considered plate scales: 50 mas (TRICK), 32 mas (Nyquist/2 in H) and 17 mas (Nyquist in H)





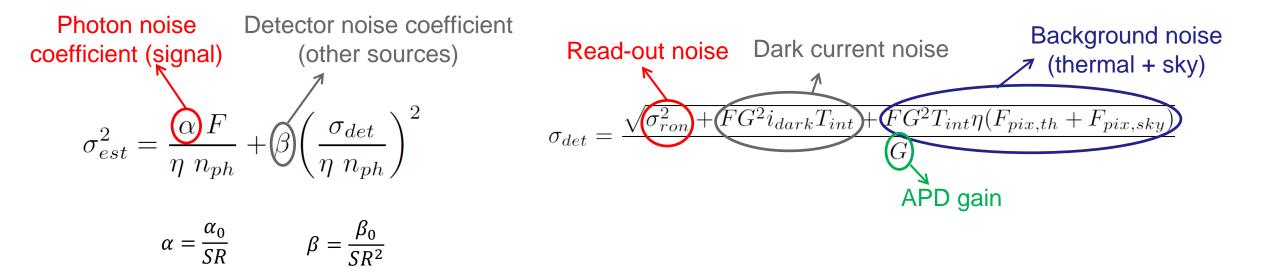
Noise error



[Plantet13&15, Opt. Exp.]

[Plantet16, SPIE]

- Computed from noise propagation coefficients
- Noise coefficients scaled with Strehl Ratio ($\Leftrightarrow n_{ph} = SR \times n_{ph_0}$)



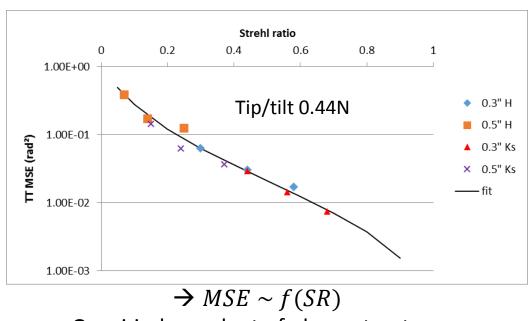
 $lpha_0$, eta_0 noise propagation coefficients at diffraction limit



Aliasing error



- LGS AO corrected phase screens from Fourier PSDs
- Estimation of turbulent tip/tilt/focus at 1 kHz
- Noiseless images
- NGS at 0", 20" or 40"

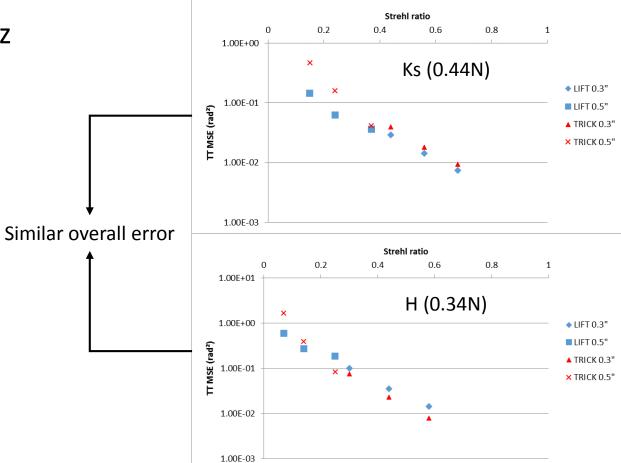


Quasi-independent of phase structure

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TRICK vs LIFT

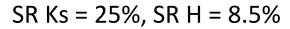
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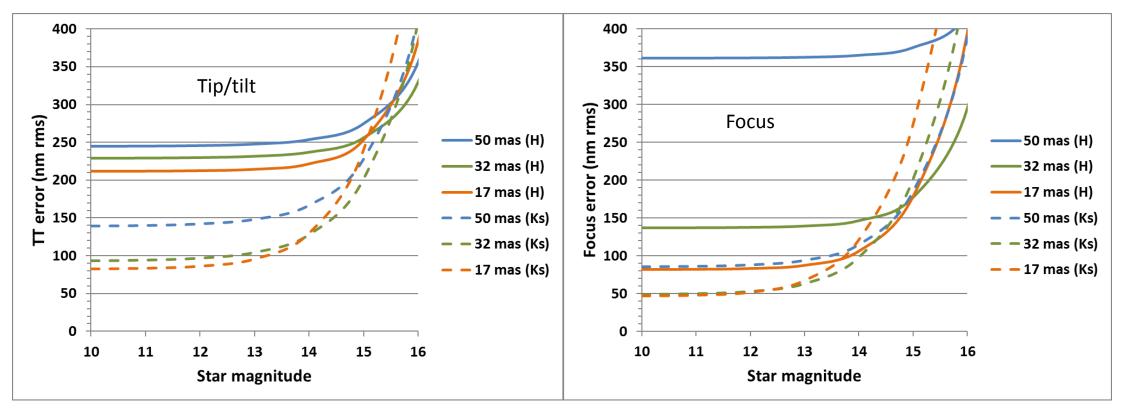
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Expected performance



Noise + aliasing @ 300 Hz





Low sampling (32 mas) better in Ks

Good sampling (17 mas) better in H

No sensing in Ks in new design ightarrow 17 mas on Selex

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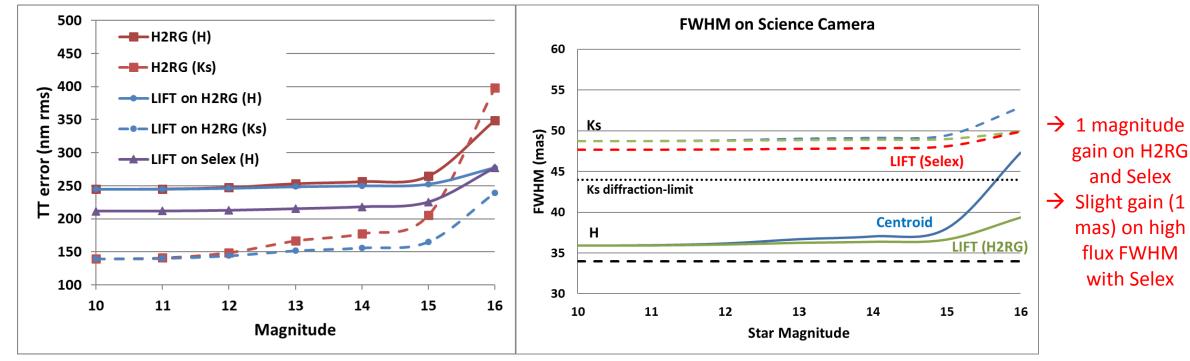
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Comparison with TRICK

- Computation of noise coefficients for under-sampled centroid
- Same aliasing error for both sensors
- Frequency adapted to magnitude (800 Hz at 10, 100 Hz at 16)



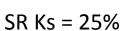
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Selex pixel scale = 17 mas

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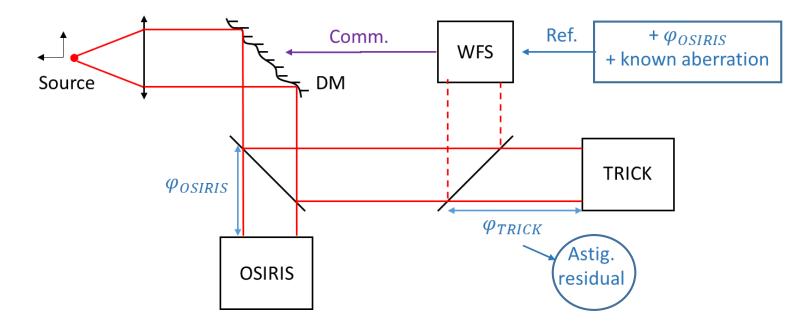


Experiments principle



Goal: Demonstrate LIFT's ability to estimate tip/tilt/focus at very low sampling (< 0.5 N)

Astigmatism offset from NCPA (operational)





Tilt estimation and PSF model

AO4ELT5

Creation of image at sampling S < Nyquist:

- **PSF at kS:** $PSF_0(x, y) = h(x, y) \times III_{l_{pix}/k}(x, y)$
- Convolution with (resized) pixel response: $PSF_1(x, y) = FT^{-1}\{FT[PSF_0(x, y)] \times \widetilde{f_{pix}}(ku, kv)\}$
- Sample the result at S: $PSF(x, y) = PSF_1(x, y) \times III_{l_{pix}}(x, y)$

1.0

Response (normalized) .0 .5

0.0

-40

-20

0

Distance from Pixel Center [µm]

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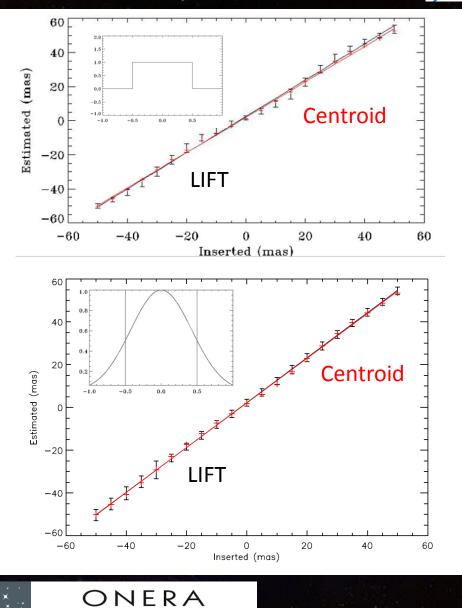
20

40

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[Barron06]

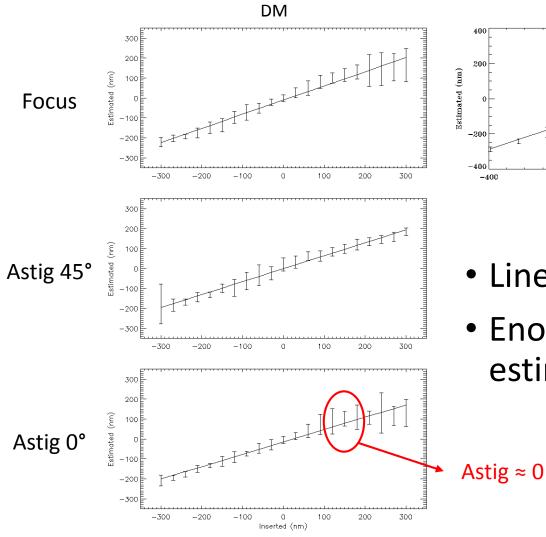


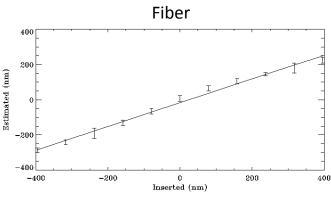
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H2RG pixel response:

Estimation of focus/astig. on TRICK







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Astigmatism offset (found from first estimation):

30 nm Z5, -140 nm Z6

 \rightarrow 145 nm (0.42 rad) total astigmatism

• Linear estimation (rms ≈ 15 nm)

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 Enough astigmatism on TRICK's path for focus estimation

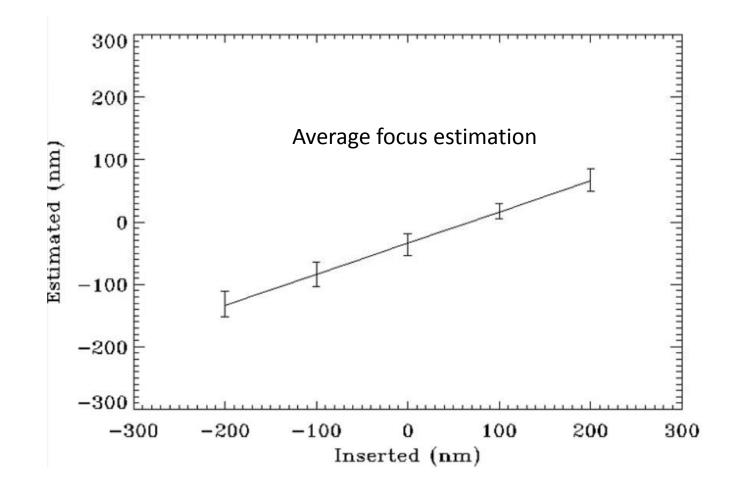


Focus estimation at SR = 20%

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- Random phase from astigmatism to 45th Zernike
- Normalization to SR = 20% (uniform)
- 40 occurrences/focus offset value
- →Linear estimation with bias ≈ 20 nm ≈ error at diffraction limit
- →No additive bias on average estimation



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On-sky data



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Coming soon!



Conclusion



- Performance evaluation:
 - Well-sampled PSF = best trade-off noise/aliasing in H \rightarrow 17 mas for Keck II design
 - 1 magnitude gain on tip/tilt w.r.t TRICK in both H and Ks band (+ focus estimation)
- Experimental validation:
 - Linear estimation of tip/tilt and focus at very low sampling (0.44 Nyquist)
 - Focus estimation can be done with SR down to 20%
- Other and future work:

[Poster Monday]

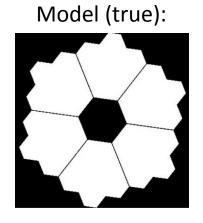
- Comparison of LIFT and the pyramid for Keck II ightarrow need for (well-sampled) LIFT confirmed
- On-sky open-loop, then closed-loop, validation of LIFT

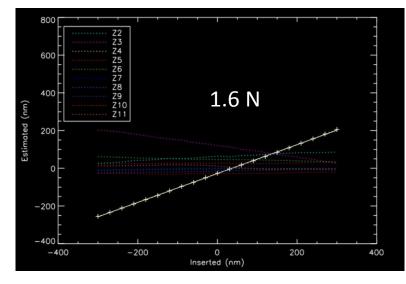


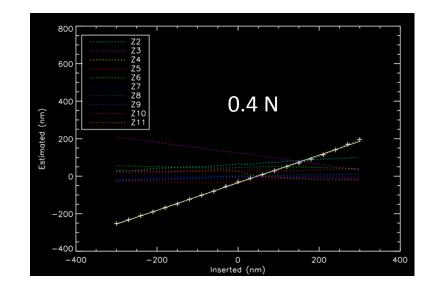
Thank you

Estimation with Keck pupil (NIRC2, Keck II)

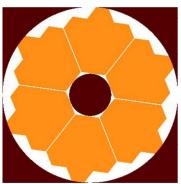


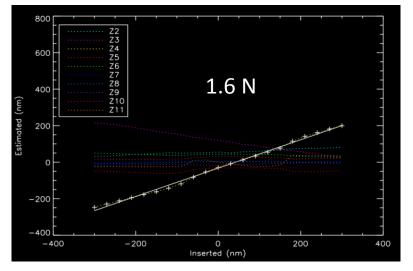




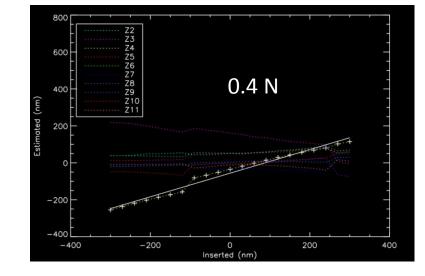








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